

TE MTRX/ SEM-VI / C8568/

Q.P. Code: 27073

Time: 3 Hours

Marks: 80

Note:

1. Question No. 1 is compulsory.
2. Attempt any three from the remaining questions.
3. Assume suitable data if required.
4. Figures to the right indicate full marks.

Q 1. Attempt any four from the following

20

- a. Define the term quality. And also explain the concept of quality.
- b. Write a short note on roughness & waviness.
- c. Difference between precision & accuracy
- d. Explain the term random sampling technique.
- e. What do you mean by p - charts & np - charts?

Q 2. a. Derive an expression for three wire method used in screw thread measurement. 10

b. Explain briefly OC curve with suitable curve. Also explain the following terms. 10

- i) Producer's risk
- ii) Consumer's risk

Q 3. a. Explain various modern SQC tools. 10

b. Explain briefly the types of gauges with neat sketches. 10

Q 4. a. Explain the following terms with respect to surface roughness parameter with neat diagrams.

10

- i) Ra
- ii) Ry
- iii) Rz
- iv) RMS

b. Explain briefly 3-D co-ordinate measuring machine with suitable diagram. 10

Q 5. a. Explain principle, working & construction of optical comparator with neat Diagram. And also write advantages & disadvantages.

10

b. The following data on the number of components were collected when the process was in control.

10

Calculate:

- The control limits for \bar{X} charts & R charts
- A new sample obtained the following reading 570, 603, 623, 583.
Is the process still in control?

Sample → Subgroup↓	1	2	3	4
1	604	612	588	600
2	597	601	607	603
3	581	570	585	592
4	620	605	595	588
5	590	614	608	604

Q 6. a) Explain briefly the quality control concept.

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b) Write a short note on Indian Standard IS919.

5

c) Explain profile projector with neat sketch.

5

$$\begin{aligned}n &= 6 \\D_4 &= 2.007 \\D_3 &= 0\end{aligned}$$